A Quantitative Evaluation of Microstructure by Electron Back-Scattered Diffraction Pattern Quality Variations

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Abstract: Band contrast (BC) is a qualitative measure of electron back-scattered diffraction (EBSD), which is derived from the intensity of the Kikuchi bands. The BC is dependent upon several factors including scanning electron microscope measurement parameters, EBSD camera setup, and the specimen itself (lattice defect and grain orientation). In this study, the effective factors for BC variations and the feasibility of using BC variations for the quantification of microstructure evolutions have been investigated. In addition, the effects of the lattice defect and the grain orientation on the BC variations are studied. Next, a shear-deformed microstructure of 316L stainless steel, which contains nanosized grains and a large portion of twin boundaries, is revealed by BC map and histogram. Recovery and recrystallization of shear-deformed 316L stainless steel are displayed by BC variations during isothermal annealing at 700 and 800°C, respectively. It is observed that the BC turns bright as the shear-deformed crystal structure is recovered or recrystallized.

Key words: EBSD, band contrast, annealing, microstructure, recovery, recrystallization

INTRODUCTION

X-ray or neutron beam diffraction is a conventional tool for determining the variations of crystal lattice structures in a macroscale, and it makes measurements on innumerable grains. Electron beam diffraction is a tool for determining such variations in a microscale, and it makes measurements on a grain-by-grain basis. Many important behaviors of the material are controlled by the local characteristics rather than by global averages, and this has been a strong driving force in the development of electron beam applications, especially the electron back-scattered diffraction (EBSD) method (Wilkinson & Dingley, 1991, 1992; Krieger Lassen et al., 1992; Wilkinson et al., 1992; Mukherjee et al., 1995).

With the advanced spatial resolution, EBSD has been widely used to probe both elastic and plastic strains. Basically, unstrained materials show sharper and higher-quality EBSD patterns. However, the presence of elastic strain, or population of defects associated with the strain, leads to the broadening of diffracted patterns and lower quality of EBSD pattern. For example, the distribution of plastic deformation in Al matrix composites reinforced with SiC fibres are characterized by EBSD pattern variations (Wilkinson & Dingley, 1992; Wilkinson et al., 1992; Mukherjee et al., 1995). The quality of the EBSD pattern is usually quantified by band contrast (BC), which is derived from the average intensity of the Kikuchi bands with respect to the overall intensity within an EBSD pattern. BC can be evaluated by 256 (0–255) different levels of brightness: “0” corresponds to the bad EBSD pattern quality and black color, and “255” corresponds to the good EBSD pattern quality and white color. The observed brightness can be mapped into a grayscale image, and it shows detailed features of the microstructure, such as boundaries. The statistical distribution of brightness can be plotted in a diagram, and it can be quantitatively compared with diagrams of other samples (BC histogram).

The EBSD pattern is generally obtained by 70° tilting of a sample under a scanning electron microscope (SEM). The interaction depth between the incident electron beam and the sample is very shallow (tens of nanometers), and most of the diffracted signal is generated from the sample surface. Therefore, the signals are very sensitive to the SEM/EBSD measurement condition and surface topology. Before evaluating material characteristics, it should be confirmed that the EBSD pattern and the corresponding BC are always consistent with each other regardless of the measurement condition or surface topology.

In this study, the effective parameters for BC variations are investigated, and the feasibility of using BC variations for quantification of microstructure evolutions has been studied. The BC variation factors such as SEM parameters, EBSD camera setup, lattice defects, and grain orientations were investigated, and the recovery and recrystallization of the sample were quantified by BC map and histogram.

MATERIALS AND METHODS

Four groups of samples were used in this study: dual-phase steel (Fe–1.3Mn–0.3C), interstitial-free (IF) steel, gold wire, and simple shear-deformed type 316L stainless steel. Dual-phase steel (Fe–1.3Mn–0.3C) was used to investigate the relationship between the SEM/EBSD parameters and BC variations. Two phases, ferrite phase with a body-centered cubic (bcc) structure and martensite phase with a BCT...
structure, showed two characteristically different peaks in the BC histogram, and they appeared useful to evaluate the effects of the SEM measuring parameters and EBSD camera setup on the BC variations.

An IF steel sample was used to investigate the effect of grain orientations on the BC variations. Recrystallized grains of IF steel clearly showed the orientation differences of each grain, and the corresponding BC differences of each grain were evaluated.

A recrystallized gold wire sample was used to investigate the relationship between the lattice strain and BC distributions. The grain and grain boundaries could be distinguished by a particular value of BC, and the corresponding grain map has been estimated.

Simple shear-deformed 316L stainless steel was used for the investigation of the relationship of the recovery and recrystallization with BC variations. The samples were subjected to an annealing process at recovery or recrystallization temperature, respectively. Square-shaped indent marks were made on the sample surface, and the same area was observed before and after the heat treatment.

To ensure that all the samples have the same surface condition, samples were subjected to electrolytic polishing under the same voltage and etchant flow condition. Electro-polishing is effective in relieving the local defects on the surface, which is usually generated during mechanical polishing of samples. An SEM/EBSD system (JSM 6500F/Oxford Inca) was used to observe the microstructural evolution and the BC variations. An acceleration voltage of 20 kV with 4 nA probe current was used for SEM, and 100-ms integration time and 100 video gains for EBSD analyses.

**RESULTS**

**SEM Measurement Parameters, EBSD Setup, and BC**

An SEM micrograph and an EBSD BC map of Fe–1.3Mn–0.3C dual-phase steel are shown in Figure 1. Two different phases in a dual-phase steel sample are identified by different brightness levels of the EBSD signal. The martensite phase is a dark-colored one, and the ferrite phase is bright-colored one. As the crystal structure of a martensite phase and a ferrite phase are all based on the bcc, they can hardly be distinguished by indexing of individual diffraction patterns. However, the formation of martensite in a ferrite matrix causes a high local dislocation density and high residual stress; therefore, the EBSD quality of the martensite phase is much lower than that of the ferrite phase, and the corresponding BC is dark.

The different phases have different BC values in the histogram as shown in Figure 2. Three characteristic peaks are observed in Figure 2a. The BC value of the first peak is estimated as 75, the second one as 150, and the last one as 220, respectively. The first peak is identified as a martensite, and the last two peaks are identified as ferrite. The second and the third characteristic peaks in Figure 2a differ in crystal orientation. The grain orientation dependency of BC in the bcc structure is discussed later (Fig. 3).

In Figures 2b–2d, BC histograms are displayed with different combinations of SEM measurement parameters and EBSD camera setup. The positions of characteristic peaks from the different phases and the BC histogram width (ΔBC) appear to be changed with SEM/EBSD measurement parameters. The relationship of BC variation with the SEM/EBSD measurement conditions is summarized in Figure 2e. It is observed that ΔBC is proportional to the product of all parameters investigated such as acceleration voltage, probe current, integration time, and video gain. Three factors, except the acceleration voltage, directly affect the amount of input signals, resulting in proportionally varying signals. It is observed that ΔBC decreased by half following the decrease of the probe current from 4 to 2 nA, the integration time from 100 to 50 ms, and the video gain from 100 to 50, respectively. It is also estimated that the acceleration voltage variation from 20 to 15 kV induced a
decrease of $\Delta BC$ by $\sim 0.75$ times—another proportional variation. Basically, $BC$ quantifies the signals within the interaction volume between the electron beam and the specimen. Many researchers suggest that there is a linear relationship between the accelerating voltage and the interaction volume (Engler & Randle, 2010). And it could be reasonable that acceleration voltage and BC variations show a proportional relationship under the present experimental condition.

Crystal Orientation and BC

In Figure 3, the relationship between crystal orientation and BC value is illustrated. It is expected that some planes in the crystal lattice produce bands of higher intensity than others. A first-order approximation of the intensity of a diffraction band can be obtained by assuming the role of the structure factor. If the lattice is in an orientation such that the pattern contains many high-intensity reflections, then the pattern may have a higher BC value than the other cases (Wright & Nowell, 2006). Thus, there will be some grain-to-grain variations in BC simply because of the grain orientation effect. Among fully recrystallized ferrite grains in IF steel in Figure 3a, nine grains were identified by indexing of the corresponding patterns, and the BC map is displayed in Figure 3b. The different orientation of each grain is indexed in an inverse pole figure of plane normal direction in Figure 3c. From “grain 1” to “grain 9,” the crystal orientation is indexed as (001), (013), (233), (111), (137), (113), (144), (011), and (011), respectively. In Figure 3d, BC values of each grain orientations are marked on the BC histogram. It is observed that the grains close to the (011) plane reveal the highest BC values. It is also true that (011) plane generates the highest peak in the X-ray diffraction of the bcc lattice.

Lattice Strain and BC

In Figure 4, three different areas of one gold wire sample are observed by EBSD. The BC values vary with different grain orientations, and the BC histogram shows different distributions of peaks because only several grains are included in
each map. It is found that a particular BC value could distinguish the grains from the grain boundaries in the histograms. In Figure 4d, an arbitrary number of 90 for a BC value is indicated; i.e., when the BC value is >90, the BC appears to be highly dependent on the crystal orientation of the sample; however, when the BC value is <90, the BC is dependent on the lattice strain or defects in the sample such as dislocations and grain boundaries, not on the crystal orientation.

Recovery, Recrystallization, and BC
In Figure 5, microstructural evolution of a shear-deformed 316L stainless-steel sample after isothermal annealing is illustrated by BC variations. The same areas of the sample are observed before and after the annealing treatment. In Figures 5a and 5c, the shear band shows an inclination of about 45° from the shear direction, but the grains appear parallel to the shear band direction. In Figures 5b and 5d, the microstructural evolutions are shown by BC variations after isothermal annealing at 700 and 800°C, respectively. The configuration of the BC map including the fine twin boundaries does not seem to have changed much after the annealing process at 700°C, and the micrometer-sized grains appear similar in Figures 5a and 5b. When the annealing temperature is raised to 800°C, it is observed that grains are mostly recrystallized. In Figure 5d, uniform equi-axed grains are developed by recrystallization, and the BC map becomes clearer. It is generally accepted that twin boundaries are highly resistant to boundary deterioration during annealing, and the dark area looks relatively stable because of the high boundary density of twin boundaries. The BC histograms in Figure 6, which correspond to pre- and postannealing processes of the shear-deformed 316L stainless steel specimens, suggest that the position of the peak moved to the higher BC value after annealing. The brightness change seems to be related to the grain boundary density.

**Figure 3.** Crystallographic orientation dependency of band contrast are observed from an interstitial-free steel. a: Grains displayed by random brightness (grains are recrystallized, and there is no preferred orientation). Some grains that have specific orientation along the normal direction (ND) have been identified by numbers (b) corresponding to the grain map of band contrast; c) numbered grains are expressed in the ND inverse pole space. d: Peak intensity and positions of numbered grains are indexed in the histogram of band contrast.
Figure 4. Band contrast (BC) maps of a recrystallized 99.9999% pure gold wire sample; a specific BC value of 90 is indicated for estimating three different BC histograms.

Figure 5. Band contrast (BC) maps of a shear-deformed 316L stainless steel sample. a, c: BC map of an ECAP-processed sample before the annealing process, and BC map the sample after annealing (b) at 700°C and (d) 800°C for 1 h.

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SUMMARY

In this study, the effective parameters for BC variations are investigated and the feasibility of using BC variations for quantification of microstructure evolutions has been studied. It is found that the BC is in proportion to SEM
measurement parameters of acceleration voltage and probe current and the EBSD camera setup of integration time and video gain. The relationship between BC and crystal orientation is investigated, and it is found that the grain that has closer orientation to the (011) plane shows the highest BC value. A particular BC value of 90 which distinguishes the grain boundaries from grains is proposed in this study. The microstructure of shear-deformed 316L stainless steel is characterized by the BC map and histogram. It is observed that the BC becomes brighter as the crystal structure of the shear-deformed 316L stainless steel is recovered by annealing at 700°C, and becomes clearer and distinguishable by BC value when recrystallized by annealing at 800°C.

**ACKNOWLEDGMENT**

This research was supported by Nuclear R&D program through the National Research Foundation of Korea (NRF) funded by the Ministry of Education, Science and Technology (2011-0094107).

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Figure 6. Band contrast (BC) histogram variations of shear-deformed 316L stainless steel samples before and after the annealing at (a) 700°C and (b) 800°C for 1 h. The intensity of the brighter region became lowered and the position of the peak moved to the higher BC value.